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Product data sheet

1. General description

N-channel enhancement mode vertical Double-Diffused Field-Effect Transistor (D-MOSFET) in a SOT89 (SC-62) medium power and flat lead Surface-Mounted Device (SMD) plastic package.

2. Features and benefits

- Direct interface to Complementary (C-MOS) transistor and Transistor-Transistor Logic (TTL) devices.
- Very fast switching
- No secondary breakdown

3. Applications

- Relay driver
- High-speed line driver
- Load-side loadswitch
- Switching circuits

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j = 25 °C		-	-	200	V
V_{GS}	gate-source voltage			-20	-	20	V
I _D	drain current	V _{GS} = 10 V; T _{amb} = 25 °C	[1]	-	-	0.4	Α
Static characteristics							
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 0.4 \text{ A}; T_j = 25 ^{\circ}\text{C}$		-	1.6	3	Ω

^[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm².





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5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		D —
2	D	drain	ا ا ا	
3	G	gate	3 2 1 SOT89	G 17aaa253

6. Ordering information

Table 3. Ordering information

Type number	Package					
	Name	Description	Version			
BSS87	SOT89	plastic surface-mounted package; die pad for good heat transfer; 3 leads	SOT89			

7. Marking

Table 4. Marking codes

Type number	Marking code
BSS87	KA

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Limiting values

Table 5. **Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{DS}	drain-source voltage	T _j = 25 °C		-	200	V
V _{GS}	gate-source voltage			-20	20	V
I _D	drain current	V _{GS} = 10 V; T _{amb} = 25 °C; t ≤ 5 s	[1]	-	0.7	Α
		V _{GS} = 10 V; T _{amb} = 25 °C	[1]	-	0.4	Α
		V _{GS} = 10 V; T _{amb} = 100 °C	[1]	-	0.2	Α
I _{DM}	peak drain current	T_{amb} = 25 °C; single pulse; $t_p \le 10$ μs		-	1.6	Α
P _{tot}	total power dissipation	T _{amb} = 25 °C	[2]	-	0.58	W
			[1]	-	1	W
		T _{sp} = 25 °C		-	12.5	W
Tj	junction temperature			-55	150	°C
T _{amb}	ambient temperature			-55	150	°C
T _{stg}	storage temperature			-65	150	°C
Source-drain	diode		'	'		,
I _S	source current	T _{amb} = 25 °C	[1]	-	0.4	Α

Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm². Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

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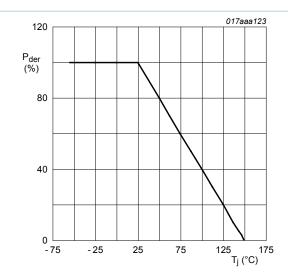


Fig. 1. MOSFET transistor: Normalized total power dissipation as a function of junction temperature

$$P_{\textit{der}} = \frac{P_{\textit{tot}}}{P_{\textit{tot}(25^{\circ}\textit{C})}} \times 100 \%$$

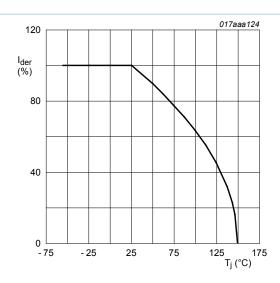
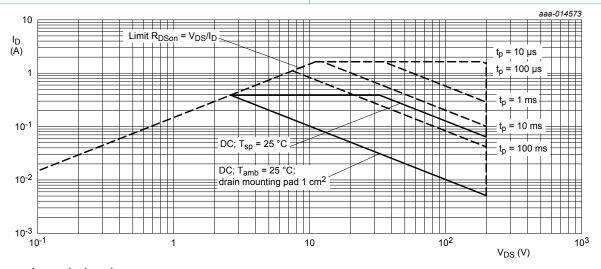


Fig. 2. MOSFET transistor: Normalized continuous drain current as a function of junction temperature

$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100 \%$$



 I_{DM} = single pulse

Fig. 3. Safe operating area; junction to ambient; continuous and peak drain currents as a function of drain-source voltage

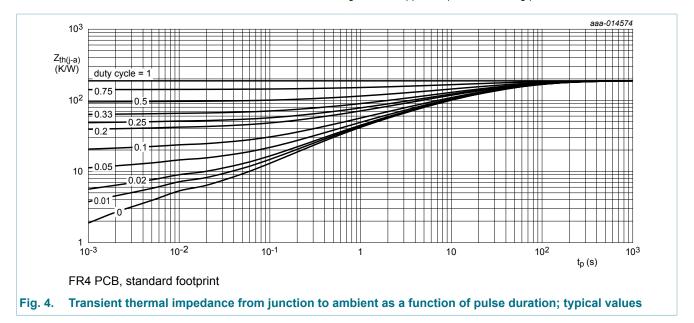
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9. Thermal characteristics

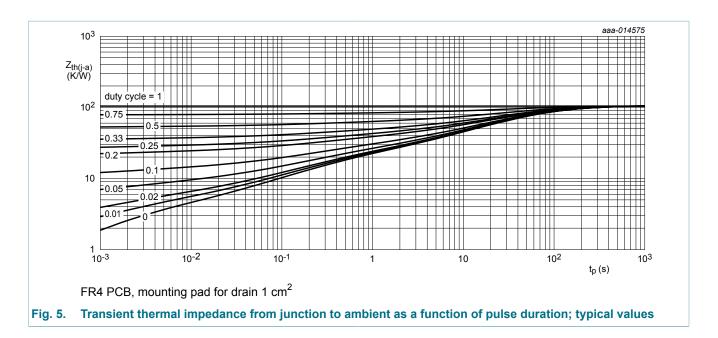
Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
fr	thermal resistance		[1]	-	190	216	K/W
	from junction to ambient		<u>[2]</u>	-	105	125	K/W
	ambient	in free air; t ≤ 5 s	<u>[2]</u>	-	36	42	K/W
R _{th(j-sp)}	thermal resistance from junction to solder point			-	6	10	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm².



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10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics		·			
$V_{(BR)DSS}$	drain-source breakdown voltage	I _D = 250 μA; V _{GS} = 0 V; T _j = 25 °C	200	-	-	V
V_{GSth}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	0.8	-	2.8	V
I _{DSS}	drain leakage current	V _{DS} = 60 V; V _{GS} = 0 V; T _j = 25 °C	-	-	200	nA
		V _{DS} = 200 V; V _{GS} = 0 V; T _j = 25 °C	-	-	60	μΑ
I _{GSS}	gate leakage current	V _{GS} = 20 V; V _{DS} = 0 V; T _j = 25 °C	-	-	100	nA
		V _{GS} = -20 V; V _{DS} = 0 V; T _j = 25 °C	-	-	-100	nA
R _{DSon} drain-source on-state resistance	drain-source on-state	V _{GS} = 10 V; I _D = 0.4 A; T _j = 25 °C	-	1.6	3	Ω
	resistance	V _{GS} = 10 V; I _D = 0.4 A; T _j = 150 °C	-	3.7	7	Ω
		V _{GS} = 4.5 V; I _D = 0.3 A; T _j = 25 °C	-	1.9	4	Ω
g _{fs}	forward transconductance	V_{DS} = 25 V; I_{D} = 0.4 A; T_{j} = 25 °C	-	0.8	-	S
Dynamic ch	naracteristics		'	1		
Q _{G(tot)}	total gate charge	V _{DS} = 50 V; I _D = 0.25 A; V _{GS} = 10 V;	-	5.5	10	nC
Q _{GS}	gate-source charge	T _j = 25 °C	-	0.3	-	nC
Q_{GD}	gate-drain charge		-	1.4	-	nC
C _{iss}	input capacitance	V _{DS} = 25 V; f = 1 MHz; V _{GS} = 0 V;	-	100	120	pF
C _{oss}	output capacitance	T _j = 25 °C	-	20	30	pF
C _{rss}	reverse transfer capacitance		-	10	15	pF
t _{d(on)}	turn-on delay time	V _{DS} = 50 V; I _D = 0.25 A; V _{GS} = 10 V;	-	2.7	6	ns
t _r	rise time	$R_{G(ext)} = 6 \Omega$; $T_j = 25 ^{\circ}C$	-	3.7	6	ns
t _{d(off)}	turn-off delay time		-	16.4	30	ns
t _f	fall time		-	7.5	20	ns
Source-dra	in diode			1	1	
V _{SD}	source-drain voltage	$I_S = 0.4 \text{ A}; V_{GS} = 0 \text{ V}; T_i = 25 ^{\circ}\text{C}$	-	0.8	1.2	V

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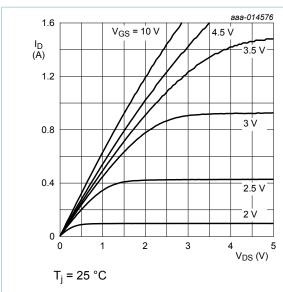


Fig. 6. Output characteristics: drain current as a function of drain-source voltage; typical values

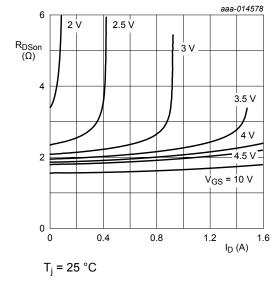


Fig. 8. Drain-source on-state resistance as a function of drain current; typical values

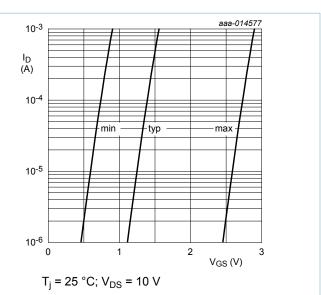


Fig. 7. Sub-threshold drain current as a function of gate-source voltage

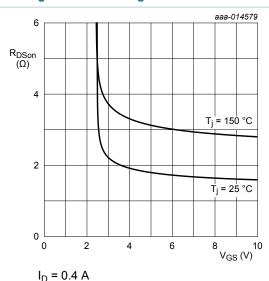


Fig. 9. Drain-source on-state resistance as a function of gate-source voltage; typical values

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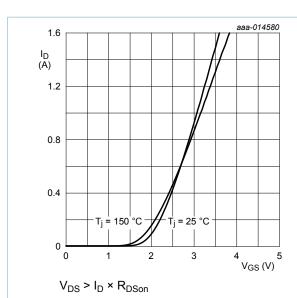


Fig. 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values

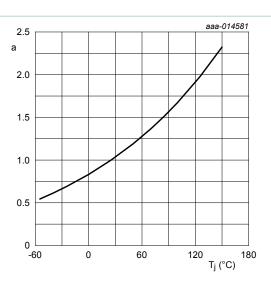


Fig. 11. Normalized drain-source on-state resistance as a function of junction temperature; typical values

$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

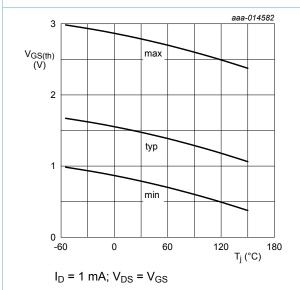
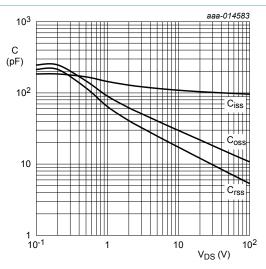


Fig. 12. Gate-source threshold voltage as a function of junction temperature



 $f = 1 MHz; V_{GS} = 0 V$

Fig. 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

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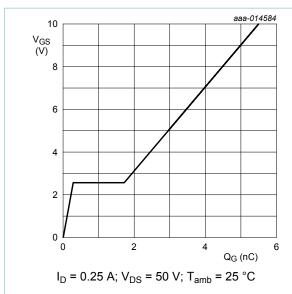


Fig. 14. Gate-source voltage as a function of gate charge; typical values

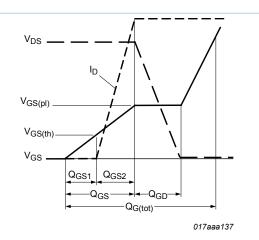


Fig. 15. MOSFET transistor: Gate charge waveform definitions

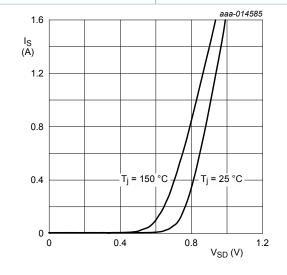
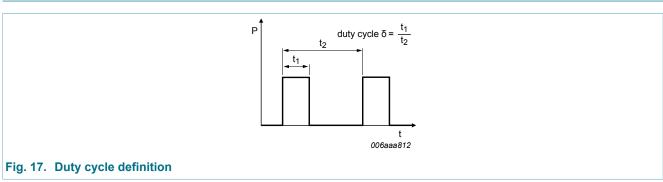


Fig. 16. Source current as a function of source-drain voltage; typical values

11. Test information

 $V_{GS} = 0 V$



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12. Package outline

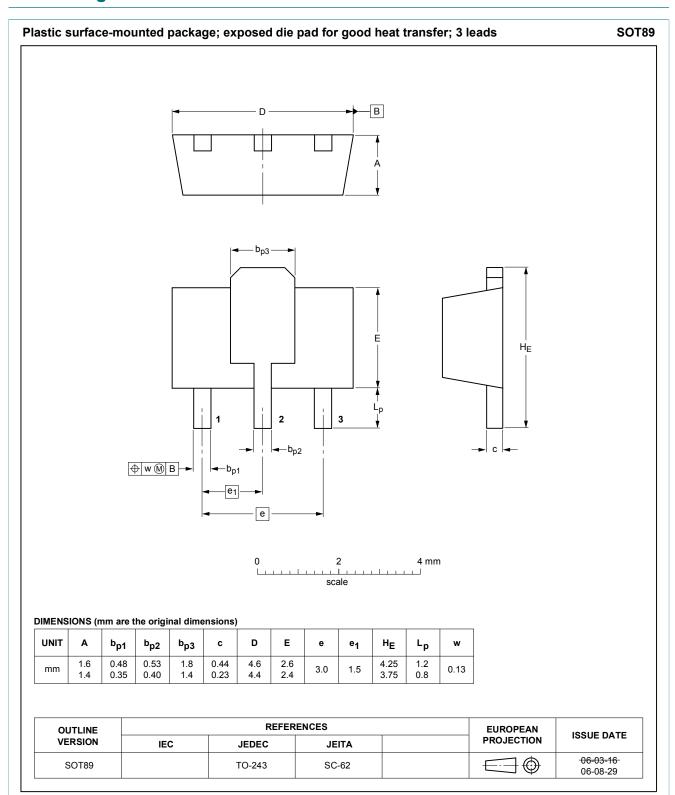


Fig. 18. Package outline SOT89

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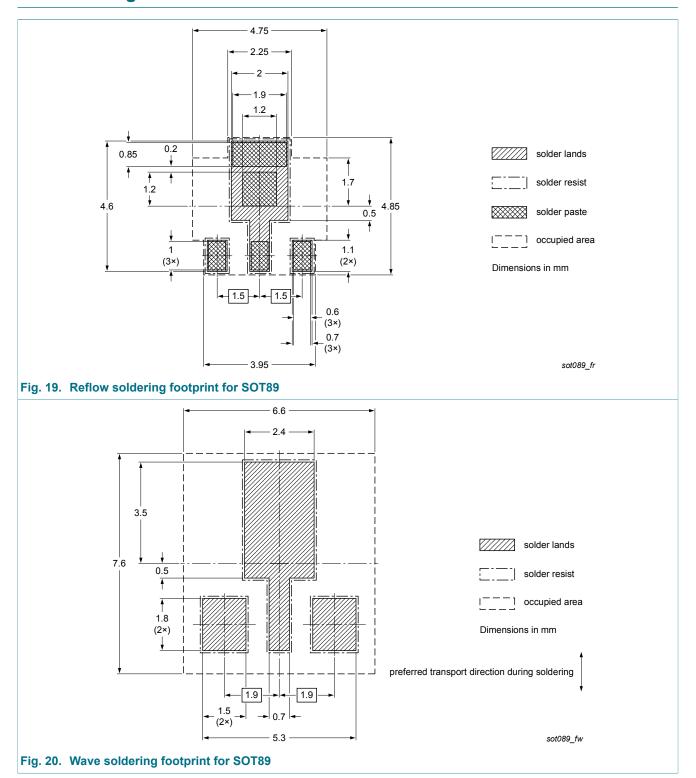
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13. Soldering



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14. Revision history

Table 8. Revision history

Data sheet ID	Release date	Data sheet status	Change notice	Supersedes
BSS87 v.5	20141209	Product data sheet	-	BSS87 v.4
Modifications:	Figure 3 corrected.			
BSS87 v.4	20140815	Product data sheet	-	BSS87 v.3
BSS87 v.3	20010518	Product specification	-	BSS87 v.2
BSS87 v.2	19970623	Product specification	-	BSS87 v.1

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15.1 Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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